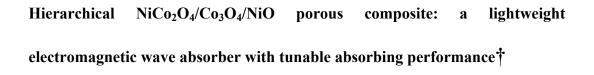
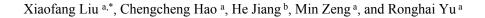
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Supplementary Information





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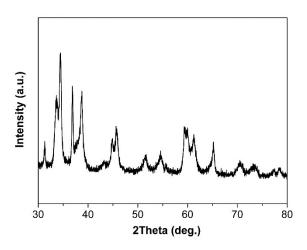


Fig. S1 XRD pattern of the precursor.

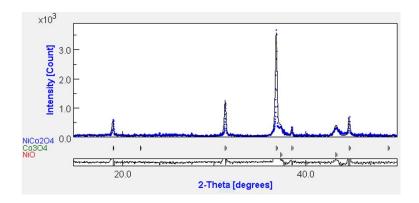


Fig. S2 XRD pattern and Rietveld analysis pattern of NiCo₂O₄/Co₃O₄/NiO.